

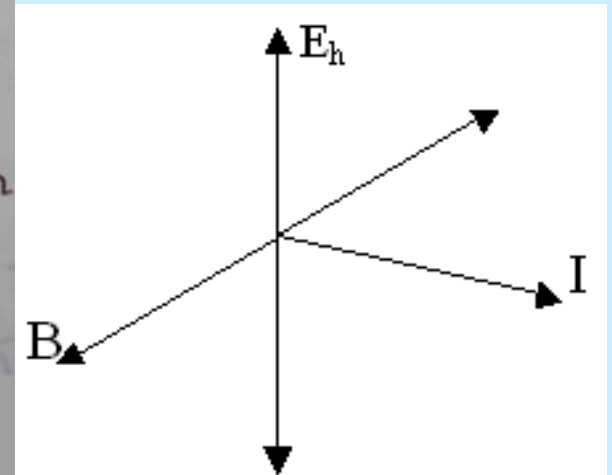
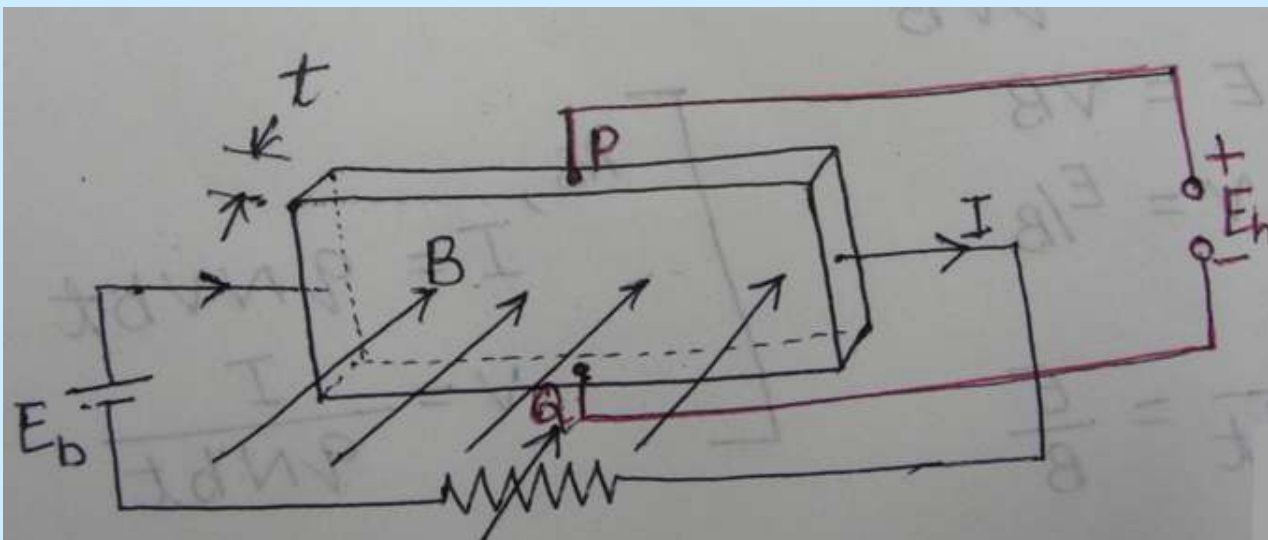
*Types Sensor and Transducer*

## *Hall Effect*

*Hall effect device (Edwin Hall discovered this effect in 1879)*

*When a conductor is kept perpendicular to the magnetic field and a direct current is passed through it then a potential difference exists across its edge in the perpendicular direction of current as well as magnetic field.*

*This emf is so small that it is difficult to measure.*



## *Types Sensor and Transducer*

### *Hall Effect*

*But for some semiconductors such as Germanium, this emf is enough for measurement with a moving coil instrument.*

*This phenomenon is known as Hall effect.*

*Let us suppose, in a strip of semiconductor in which current  $I$  is passing, we have  $I = qNvbt$*

*Where,  $q$  = charge of each carrier*

*$N$  = no. of charge carrier per unit volume.*

*$v$  = average velocity of charge carrier in the direction of current.*

*$b$  = width ,  $t$  = thickness*

*According to Fleming left hand rule they experience a force*

$$F_m = qvB \quad B = \text{flux density}$$

*an electric field starts existing because of collection of charge carriers and it exerts a force on charge carriers with opposite direction of force  $F_m$ .*

## *Types Sensor and Transducer*

### *Hall Effect*

*At equilibrium magnetic force is equal to the electric force.  
Force on the charge carriers due to electric field  $E$  is given by*

$$F_E = qE$$

*At equilibrium : -*

$$F_E = F_m$$
$$qE = qvB$$

Where,

$q$  = charge of each carrier

$N$  = no. of charge carrier per unit volume.

$v$  = average velocity of charge carrier in the direction of current.

$b$  = width ,  $t$  = thickness

$B$  = flux density

$$E = vB$$

$$E$$

$$v = \frac{E}{B}$$

$$\frac{I}{qNbt} = \frac{E}{B} \quad \text{as,}$$

$$E = \frac{IB}{qNbt}$$

$$I = qNvbt$$

$$v = \frac{I}{qNbt}$$

## *Types Sensor and Transducer*

### *Hall Effect*

*Now Electric field is uniform throughout the width of semiconductor, so potential difference  $V$  at the opposite edges of the semiconductor*

$q$  = charge of each carrier

$N$  = no. of charge carrier per unit volume.

$v$  = average velocity of charge carrier in the direction of current.

$b$  = width ,  $t$  = thickness

$B$  = flux density

$$V = E \cdot b$$

$$V = \frac{IB}{qNbt} \times b = \frac{IB}{qNt}$$

$$\frac{1}{Nq} = K_H = \text{Hall coefficient}$$

$$\text{Hall Voltage } E_H \text{ or } V_H = K_H \left( \frac{BI}{t} \right) \quad B \text{ in Wb/m}^2$$

## *Types Sensor and Transducer*

# *Hall Effect*

$$E_H \text{ or } V_H = K_H \left( \frac{BI}{t} \right)$$

*So, voltage appearing at the opposite edges of the semiconductor is directly proportional to the flux density of given magnetic field.*

